

**Notice of References Cited**Application/Control No.  
09/515,760Applicant(s)/Patent Under  
Reexamination,  
MARR ET AL.Examiner  
Douglas W OwensArt Unit  
2811

Page 1 of 2

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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Page 2 of 2

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	L	US-			
	M	US-			

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